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CAPACITORS, FIXED, MICA DIELECTRIC, BASED ON TYPE CMR04 ESCC Detail Specification No. 3007/004

ISSUE 1 October 2002





ESCC Detail Specification

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CAPACITORS, FIXED, MICA DIELECTRIC, BASED ON TYPE CMR04

ESA/SCC Detail Specification No. 3007/004



space components coordination group

	Approve		ed by	
Issue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy	
Issue 2	December 1995	Pommens	Hom	



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DOCUMENTATION CHANGE NOTICE

Rev.	Rev.		CHANGE	Approved
Letter	Date	Reference	ltem	DCR No.
		This Issue supersede	s Issue 1 and incorporates the changes agreed in the	
		following DCR's:-	and the same of th	
		Cover page		None
		DCN		None
			Existing text deleted and new text added	23786
			Second sentence added	23786
		Table 1(a)	: Column headings numbered	23786
			: '±' moved from tolerance values to column heading	23786
			: Column heading corrected to 'Max Dimension C'	23786
		Table 1(b)	: Column heading 'Limit Ratings' amended to 'Maximum	23786
			Ratings'	
			No. 2, Symbol corrected to 'U _{Rac} '	23786
:			: No. 3, Symbol corrected to I _{RF} ' and 'Note 1' added to Remarks	23786
Į.		;	: No. 4, Symbol corrected to 'Top' and 'Tamb' added to Remarks	23786
			: No. 5, Symbol corrected to 'T _{stq} '	23786
			: No. 4, Characteristic amended to 'Soldering	23786
			Temperature', Symbol corrected to 'Tsol' and remarks	
			moved to Note 2	
		3	: Second sentence added	21019
			: Wording amended	23786
			: Title and wording amended	23786
			: Title amended and deviation added	23786
			Deviation added	23786
			Wording amended	23786
			Test conditions and method deleted	23786
			: Title and wording amended	21025
			: Wording amended	23786
		Faia. 4.5.2	: Type Variant reference added : Note added	21021
		Para. 4.5.3.2	: '±' moved to column heading	23786 23786
		Para. 4.6	: Title amended	23786
		Para. 4.7	: Title amended	23786
		Table 2	Columns standardised and entries reordered	23786
			Nos. 1 and 2, Notes deleted	23786
			No. 1, Limits entry amended	23786
			No. 3, Symbol corrected to 'Ri'	23786
			Existing Notes deleted and new Note added	23786
		Table 3	Columns standardised	23786
		;	No. 1 amended to No. '5' and Limits entry amended	23786
		:	Note 2 added	23786
		Figure 4 :	Entry added	23786
		Table 4	Columns heading standardised	23786
		:	Entries for 'Spec. and/or Test Method' and 'Test	23786
			Condition' amended to 'As per Table 2'	
		 	Characteristic amended to 'Capacitance Change'	23786
		Table 5 :	Symbol corrected to 'VT'	23786
		Figure 5 :	Paragraph added	23786
		Para. 4.8	Title amended	23786
L				



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	DOCUMENTATION CHANGE NOTICE			
Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
		Para. 4.8.1 Para. 4.8.2 Para. 4.8.3 Para. 4.8.5 Table 6	 Title and first sentence amended Title and first sentence amended, second sentence added Title and first sentence amended New paragraph added Format amended and corrected 	23786 23786 23786 23786 23786 23786



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APPENDICES (Applicable to specific Manufacturers only) None.



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1. GENERAL

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Fixed, Mica Dielectric, based on Type CMR04. It shall be read in conjunction with ESA/SCC Generic Specification No. 3007, the requirements of which are supplemented herein.

1.2 RANGE OF COMPONENTS

The range of capacitors covered by this specification is scheduled in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitors specified herein, are scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The derating information applicable to the capacitors specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the capacitors specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram for the capacitors specified herein is shown in Figure 3.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

- (a) ESA/SCC Generic Specification No. 3007 for Capacitors, Fixed, Mica Dielectric.
- (b) MIL-C-39001, Capacitors, Fixed, Mica Dielectric.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbol is used:-

 V_T = Test Voltage.



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TABLE 1(a) - RANGE OF COMPONENTS

(1) Item No.	(2) Capacitance	(3) Tolerance	(4) Temperature Coefficient	(5) Dimensions (mm)	(6) Max. Weight
	(pF)	(±%)	(ppm/°C)	C Max.	(g)
01	11 000	1.0	0 to +70	8.5	7.0
02	12 000	1.0	0 to +70	8.5	7.0
03	13 000	1.0	0 to +70	8.5	7.0
04	15 000	1.0	0 to +70	8.5	7.0
05	16 000	1.0	0 to +70	8.5	7.0
06	18 000	1.0	0 to +70	8.5	7.0
07	20 000	1.0	0 to +70	8.5	7.0
08	22 000	1.0	0 to +70	11.8	8.0
09	24 000	1.0	0 to +70	11.8	8.0
10	27 000	1.0	0 to +70	11.8	8.0
11	30 000	1.0	0 to +70	11.8	8.0
12	33 000	1.0	0 to +70	11.8	8.0
13	36 000	1.0	0 to +70	11.8	8.0
14	39 000	1.0	0 to +70	11.8	8.0
15	43 000	1.0	0 to +70	11.8	8.0
16	47 000	1.0	0 to +70	11.8	8.0
17	51 000	1.0	0 to +70	11.8	8.0

TABLE 1(b) - MAXIMUM RATINGS

No.	Characteristics	Symbol	Maximum Ratings	Unit	Remarks
1	Rated Voltage d.c.	U _R	300	V	
2	Rated Voltage a.c.	U _{Rac}	150	Vrms	(50/60Hz)
3	R.F. Current	I _{RF}	4.0	Arms	Note 1
4	Operating Temperature Range	T _{op}	-55 to +125	°C	T _{amb}
5	Storage Temperature Range	T _{stg}	-65 to +150	°C	
6	Soldering Temperature	T _{sol}	+ 245	°C	Note 2

NOTES

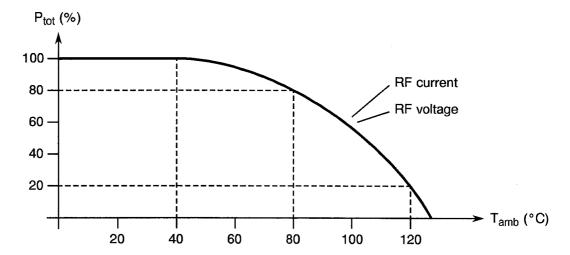
- 1. At $T_{amb} \le +40$ °C. For derating at $T_{amb} > +40$ °C, see Figure 1.
- 2. Duration 10 seconds maximum at a distance of not less than 1.5mm from the device body.



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FIGURE 1 - PARAMETER DERATING INFORMATION

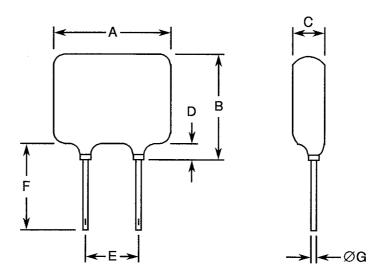




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FIGURE 2 - PHYSICAL DIMENSIONS



Symbol	Millim	netres	
Symbol	Min.	Max.	
Α	-	20.5	
В	_	24	
С	See Ta	ble 1(a)	
D	-	4.5	
E	9.5	10.5	
F	30	-	
ØG	0.9	1.1	

FIGURE 3 - FUNCTIONAL DIAGRAM

——||^C



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4. REQUIREMENTS

4.1 GENERAL

The complete requirements for procurement of the capacitors specified herein are stated in this specification and ESA/SCC Generic Specification No. 3007 for Capacitors, Fixed, Mica Dielectric. Deviations from the Generic Specification, applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 Deviations from Special In-process Controls

None.

4.2.2 Deviations from Final Production Tests (Chart II)

(a) The Temperature Coefficient Measurement shall be performed during Final Production Tests.

4.2.3 <u>Deviations from Burn-in and Electrical Measurements (Chart III)</u>

(a) Para. 9.3.3, Electrical Measurements at High and Low Temperatures: Not applicable.

4.2.4 Deviations from Qualification Tests (Chart IV)

(a) Para. 9.14, Terminal Strength: Applied Force = 23N.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

(a) Para. 9.14, Terminal Strength: Applied Force = 23N.

4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the capacitors specified herein shall be verified in accordance with the requirements set out in Para. 9.5 of ESA/SCC Generic Specification No. 3007 and they shall conform to those shown in Figure 2 of this specification.

4.3.2 Weight

The maximum weight of the capacitors specified herein shall be as specified in Table 1(a).

4.3.3 Terminal Strength

The requirements for terminal strength testing are specified in Section 9 of ESA/SCC Generic Specification No. 3007.



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4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the capacitors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 <u>Case</u>

Phenolic resin-dipped and epoxy impregnating.

4.4.2 Lead Material and Finish

The lead material shall be Type 'A' with Type '4' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.5 MARKING

4.5.1 General

The marking of components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking as specified, as much as space permits shall be marked and the marking information, in full, shall accompany the component in its primary package.

The information to be marked and the order of precedence, shall be as follows:-

- (a) The SCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

4.5.2 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:-

	3	800700401B
Detail Specification Number		
Type Variant (see Note)		
Testing Level (B or C, as app	licable) ———	

N.B.

Marking of the Type Variant Number is mandatory. No further reference to Type Variants is made in this specification.



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4.5.3 <u>Electrical Characteristics and Ratings</u>

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Capacitance Value.
- (b) Tolerance.
- (c) Temperature Coefficient.
- (d) Rated Voltage.

The information shall be constituted and marked as follows:-

	<u>243F4V</u>
Capacitance Value (24 000pF)	
Tolerance (±1.0%)	
Temperature Coefficient (0 to +70)	
Rated Voltage (300V)	

4.5.3.1 Capacitance Values

Capacitance values shall be expressed by means of the following codes. The unit quantity for marking shall be picofarads.

Capacitance Value	Code
XX10 ³	XX3

4.5.3.2 Tolerances

The tolerances on capacitance values shall be indicated by the code letters specified hereafter.

Tolerance (±%)	Code Letter
1.0	F

4.5.3.3 Temperature Coefficient

The temperature coefficient shall be indicated by the code specified hereafter:-

Temperature Coefficient (ppm/°C)	Code	
0 to +70	4	

4.5.3.4 Rated Voltage

The rated voltage shall be indicated by the code letters specified hereafter.

Rated Voltage (U _R) (V)	Code Letter
300	V



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4.5.4 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.6.2 Electrical Measurements at High and Low Temperatures

The parameters to be measured at high and low temperatures are scheduled in Table 3. The temperature coefficient measurement shall be performed only once during final production tests.

4.6.3 Circuits for Electrical Measurements (Figure 4)

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise stated, measurements shall be performed at T_{amb} = +22±3 °C. The parameter drift values (Δ) applicable to the parameters scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3007. The conditions for burn-in shall be as specified in Table 5 of this specification.

4.7.3 <u>Electrical Circuit for Burn-in (Figure 5)</u>

Not applicable.



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TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

No. Characteristics	Charactorietics	Symbol	ESA/SCC 3007	Lin	Unit	
	Cyrribor	Test Method	Min.	Max.		
1	Capacitance	С	Para. 9.3.1.1	Note 1		pF
2	Dissipation Factor	DF	Para. 9.3.1.2	_	6.0	10-4
3	Insulation Resistance	Ri	Para. 9.3.1.3	10 ⁵	-	МΩ
4	Dielectric Withstanding Voltage	VP	Para. 9.3.1.4	2.0U _R	-	٧

NOTES

1. See Columns 2 and 3 of Table 1(a).

TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No	I Characteristics I Symbol I	Test Conditions	Limits		15-14		
No. Characteristics	Зутьы	Test Method	(Note 1)	Min.	Max.	Unit	
5	Temperature Coefficient	TC	MIL-C-39001	+25 to +85 °C	Not	e 2	ppm/°C

NOTES

- 1. This measurement shall be performed only once during the final production tests on 20% of the lot, or 20 components, whichever is less.
- 2. See Column 4 of Table 1(a).



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FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

TABLE 4 - PARAMETER DRIFT VALUES

No.	Characteristics	Symbol	Spec. and/or Test Method	Test Conditions	Change Limits (Δ)	Unit
1	Capacitance Change	<u>∆C</u> C	As per Table 2	As per Table 2	± 0.05 or (1) ± 0.1	% pF

NOTES

1. Whichever is greater.

TABLE 5 - CONDITIONS FOR BURN-IN AND OPERATING LIFE TESTS

No.	Characteristic	Characteristic Symbol		Unit
1	Ambient Temperature	T _{amb}	+ 125(+ 0 - 3)	°C
2	Test Voltage	V _T	2.0U _R	٧

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS

Not applicable.



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4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION NO. 3007)</u>

4.8.1 Electrical Measurements on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.3 <u>Measurements and Inspections on Completion of Endurance Tests</u>

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at T_{amb} = +22 ±3 °C.

4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 3007. The conditions for operating life testing shall be as specified in Table 5 of this specification.

4.8.5 Electrical Circuit for Operating Life Tests (Figure 5)

Not applicable.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESA/SCC GENERIC	SPEC. NO. 3007	MEASUREMENTS A	ND INSPECTIONS	LIMITS		ITS	
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
01	Solderability	Para. 9.7	Visual Examination	MIL-STD-202, Method 208, Solid Wire Termination Criteria	-	-	_	-
02	Resistance to Soldering Heat	Para. 9.8	Final Measurements Capacitance Dissipation Factor Insulation Resistance	After a cooling period of 10±1 mins Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	C DF Ri	Table 2 Table 2 Table 2	Item 2	pF 10 ⁻⁴ ΜΩ
03	Vibration	Para. 9.9	During Last Cycle Intermittent Contact	Open or Shorts	-	-	-	-
04	Thermal Shock	Para. 9.10	Before Test Capacitance	Table 2 Item 1	С	Table 2	Item 1	рF
05	Immersion	Para. 9.11	Initial Measurements Capacitance Final Measurements Capacitance Change	Item 04	C ΔC/C	Iten - 1.0	n 04 + 1.0	pF % or
			Dissipation Factor Insulation Resistance Dielectric Withstanding	Table 2 Item 2 Table 2 Item 3 Table 2 Item 4	DF Ri VP	- 1.0 - 0.3 × 10 ⁵ Table 2	+ 1.0 9.0 -	pF (2) 10 ⁻⁴ MΩ V
06	Barometric Pressure	Para. 9.12 1.5U _R	Surge Current	Para. 9.12 of ESA/SCC 3007	Is	-	50	mA
07	Shock (Specified Pulse)	Para. 9.13	During Last Shock Intermittent Contact	Open or Shorts	-	-	-	-
08	Terminal Strength	Para. 9.14 and Para's 4.2.4, 4.2.5 of this spec.	Visual Examination	Evidence of breaking or loosening of terminals	-	-	-	-
09	Moisture Resistance	Para. 9.15 Prior to testing condition as per Para. 9.10	Initial Measurements Capacitance Final Measurements	Table 2 Item 1 After completion of Step 6, maintain at +25±5 °C and 50±5% relative humidity for 4 to 24 hours	С	Table 2	Item 1	pF
			Capacitance Change Dissipation Factor Insulation Resistance	Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	ΔC/C DF Ri	- 1.0 - 1.0 - 0.25×10 ⁵	+ 1.0 + 1.0 9.0 -	% or pF (2) 10 ⁻⁴ MΩ
			Dielectric Withstanding	Table 2 Item 4	VP	Table 2	Item 4	٧
10	Operating Life	Para. 9.16	Initial Measurements Capacitance Intermediate Measurements	Table 2 Item 1	С	Table 2	Item 1	pF
			Capacitance Change Dissipation Factor	Table 2 Item 1 Table 2 Item 2	ΔC/C DF	- 1.0 - 1.0 -	+ 1.0 + 1.0 9.0	% or pF (2) 10-4
			Insulation Resistance Dielectric Withstanding Final Measurements	Table 2 Item 3 Table 2 Item 4	Ri VP	Table 2 Table 2	Item 3	MΩ V
			Capacitance Change	Table 2 Item 1	ΔC/C	- 1.0 - 1.0	+ 1.0 + 1.0	% or pF (2)
			Dissipation Factor Insulation Resistance Dielectric Withstanding	Table 2 Item 2 Table 2 Item 3 Table 2 Item 4	DF Ri VP	- Table 2 Table 2		10 ⁻⁴ ΜΩ V

NOTES

- 1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.
- 2. Whichever is greater.